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***MELTING DYNAMICS  
FOR DIFFERENT MATERIALS IN  
INDUCTION COLD CRUCIBLE:  
NUMERICAL SIMULATIONS  
COMPARISONS WITH EXPERIMENT***

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## *Dynamic melting simulation:*

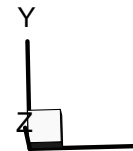


- *Some validation results: power loss and temperature measurements at Birmingham ISM*
- *TiAl melts*
- *Dome height measurements vs simulation*
- *Al melts*
- *Si melts*
- *External DC field effects*

# Melting Al, stage: 1

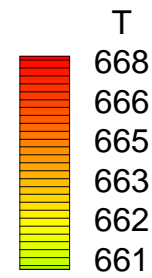
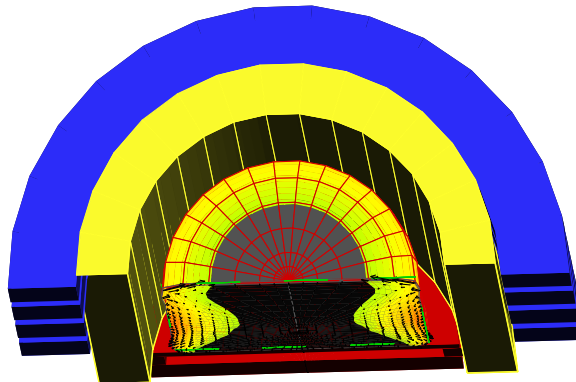


$I = 5560 \text{ A}$ ,  $f = 7000 \text{ Hz}$ ,  $I_{dc} = 0$   
el.conduct Al = 4850000.



0.5 m/s  
→

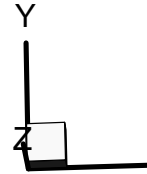
4  
coil  
turns



Time = 3 mins

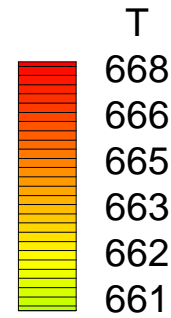
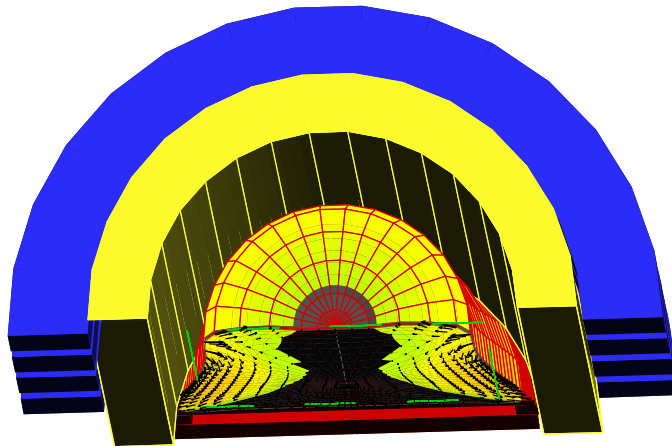
# Melting Al, stage:2

$I = 5560 \text{ A}$  ,  $f = 7000 \text{ Hz}$  ,  $I_{dc} = 0$   
el.conduct Al = 4850000.



0.5 m/s  
→

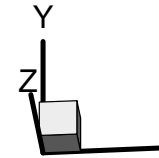
4  
coil  
turns



Time = 3 min 15 sec

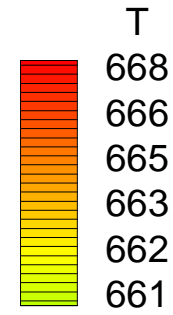
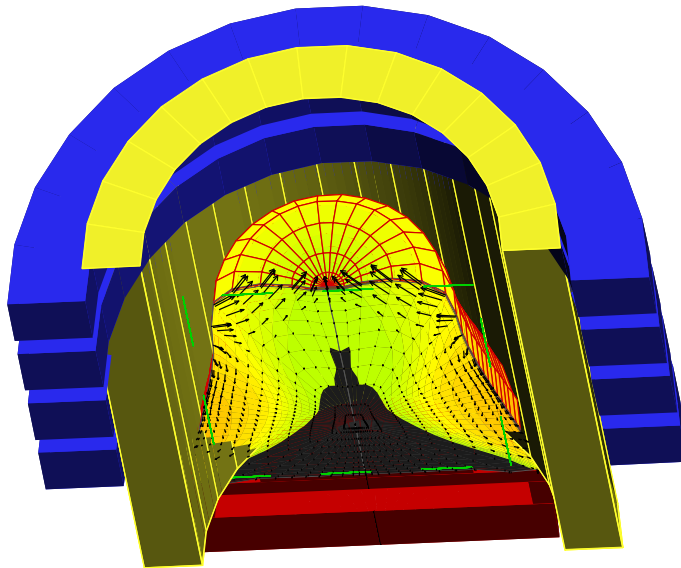
# Melting Al, stage:3

$I = 5560 \text{ A}$  ,  $f = 7000 \text{ Hz}$  ,  $I_{dc} = 0$   
el.conduct Al = 4850000.



0.5 m/s  
→

4  
coil  
turns

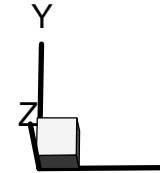


t: 1 = 3.00; P = 150 kW

Time = 3 min 30 sec

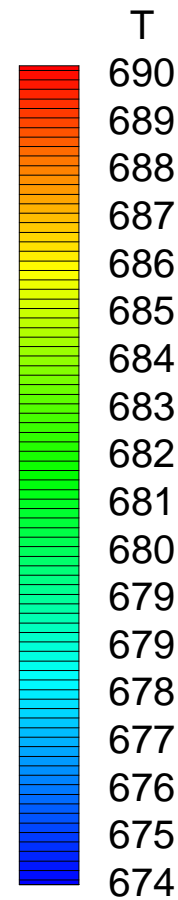
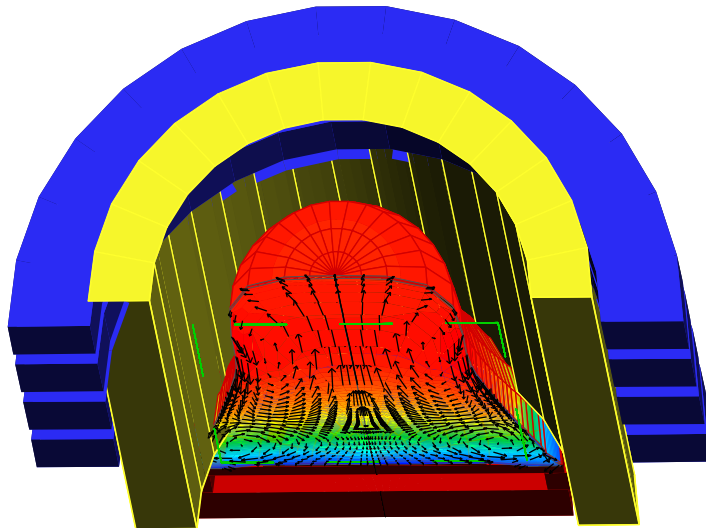
# Melting Al, stage: 5

$I = 5560 \text{ A}$  ,  $f = 7000 \text{ Hz}$  ,  $I_{dc} = 0$   
el.conduct Al = 4850000.



0.5 m/s  
→

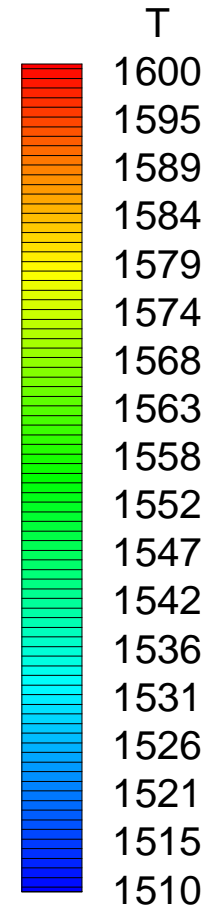
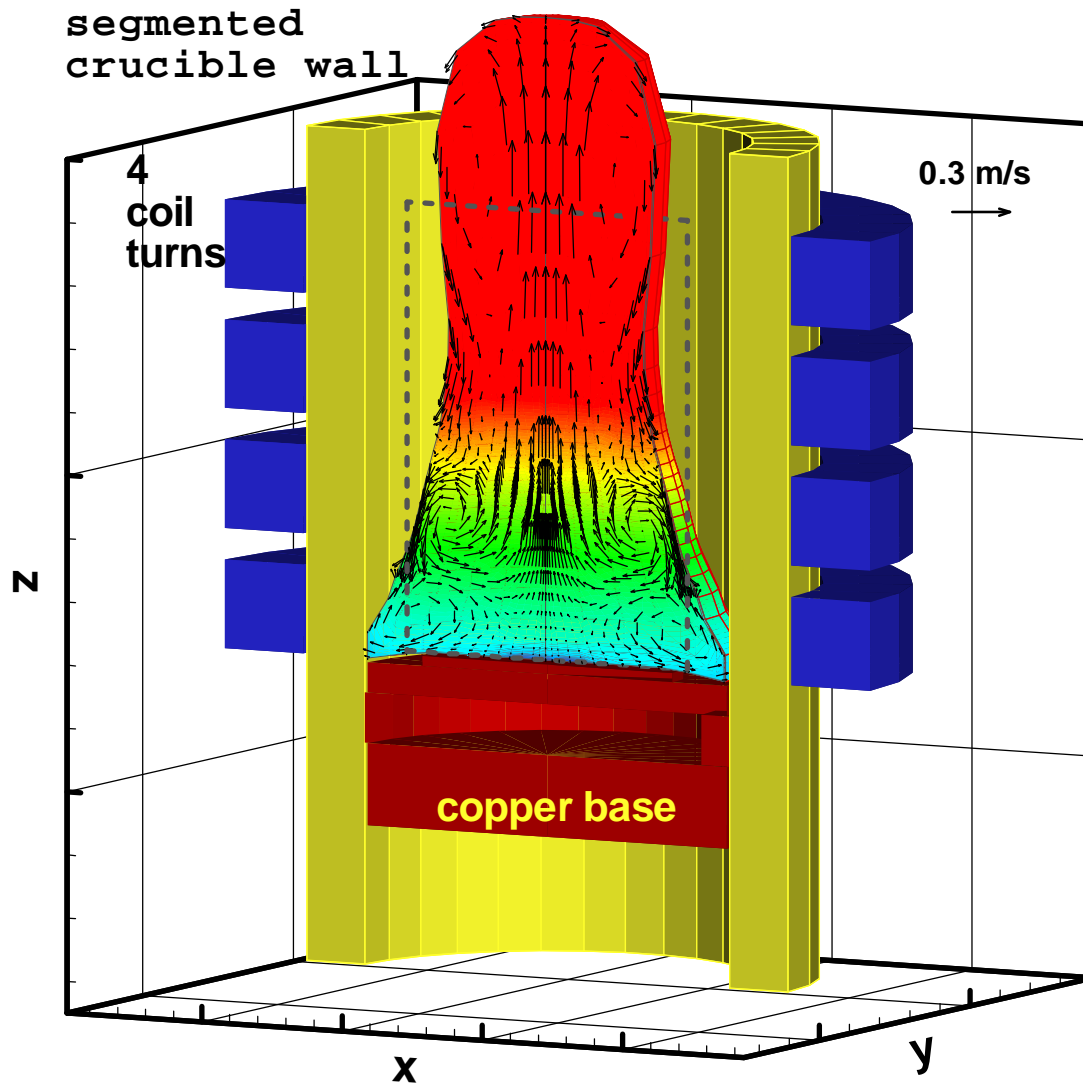
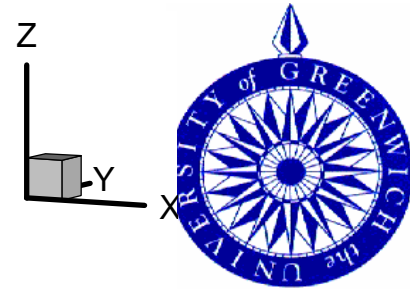
4  
coil  
turns



# Birmingham ISM: melting TiAl

t=701 s

ISM 266



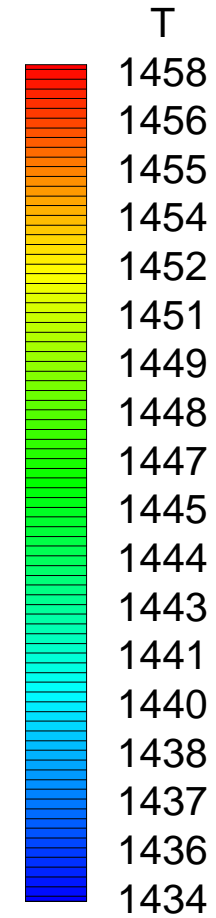
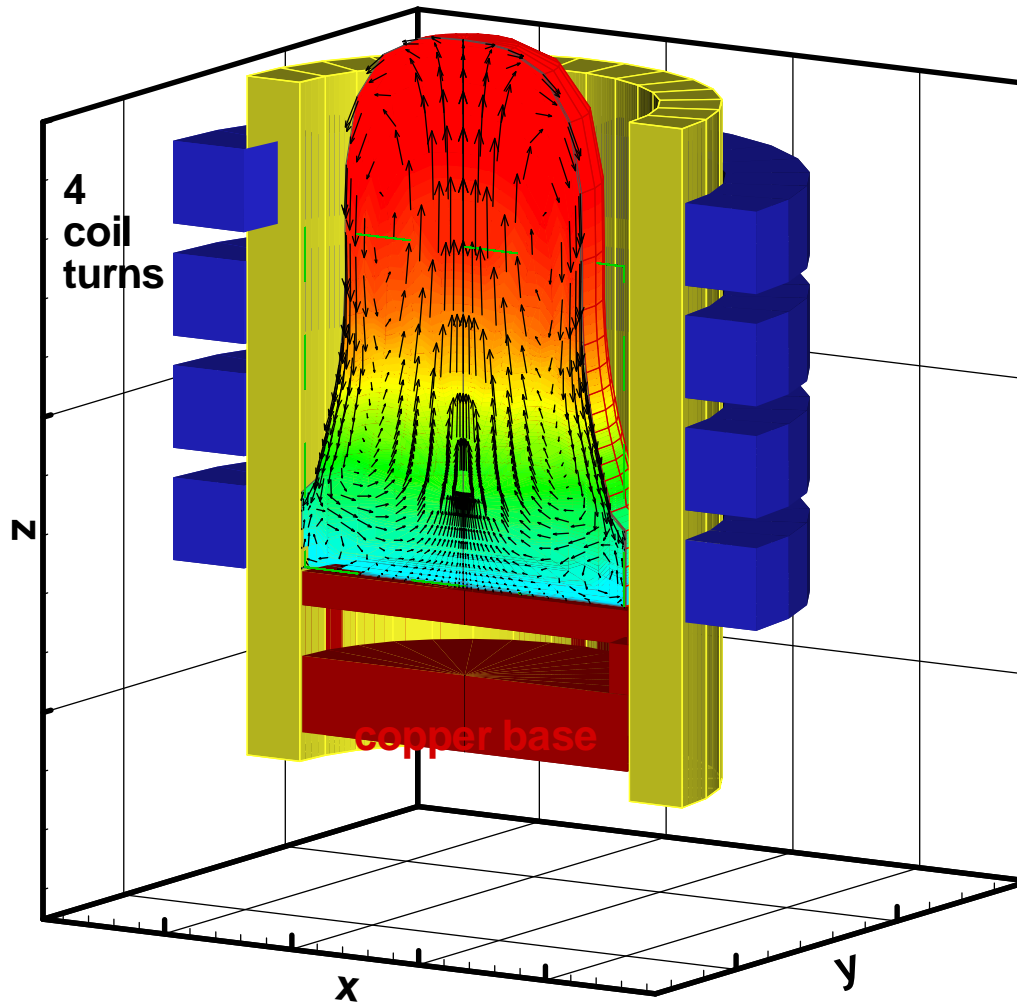
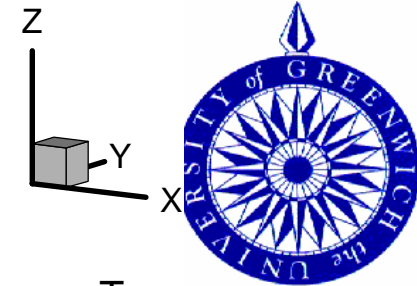
# Melting Si

$t=600s$

$I=6700\text{ A}$  ,  $f=7000\text{ Hz}$  ,  $I_{dc}=0$   
el.conduct Si = 1280000.

segmented  
crucible wall

0.5 m/s  
→





# Conclusions



- We introduce a truly dynamic model of the magnetically confined interface evolutions as applied to the melting and similar processes
- The simulations are validated against observations on the semi-commercial ISM crucible
- Low energy efficiency of the cold crucible technique can be partly improved by additional DC magnetic field  
**(faster, more stable and higher superheat)**
- The codes are sufficiently universal to adapt them to other applications for electromagnetic material processing